

Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10067296	AWAMOTO ET AL.
	Examiner	Art Unit
	Nano, Sargon N	2157

Nano, Sargon N (Assistant Examiner)	6/8/20075 (Date)	 AMELIE ETIENNE SUPERVISORY PATENT EXAMINER	Total Claims Allowed: 6	
(Legal Instruments Examiner)	(Date)	(Primary Examiner)	(Date)	
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			O.G. Print Claim(s)	O.G. Print Figure
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